

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination YAMAUCHI ET AL.	
		Examiner Harun M. Yimam	Art Unit 2611	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0047517	11-2001	Christopoulos et al.	725/87
	B	US-5,847,840	12-1998	Enari, Masahiko	358/409
	C	US-2001/0003532	06-2001	Ejiri et al.	375/240.03
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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	P					
	Q					
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NON-PATENT DOCUMENTS

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	V	
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	X	

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